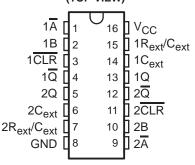
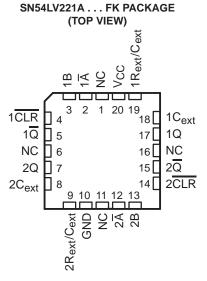
- 2-V to 5.5-V V_{CC} Operation
- Max t_{pd} of 11 ns at 5 V
- Support Mixed-Mode Voltage Operation on All Ports
- Schmitt-Trigger Circuitry on A, B, and CLR Inputs for Slow Input Transition Rates
- Overriding Clear Terminates Output Pulse
- Glitch-Free Power-Up Reset on Outputs

SN54LV221A . . . J OR W PACKAGE SN74LV221A . . . D, DB, DGV, NS, OR PW PACKAGE (TOP VIEW)



- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)



NC - No internal connection

description/ordering information

ORDERING INFORMATION

TA	PACK	AGE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	0010 D	Tube of 40	SN74LV221AD	11/0044
	SOIC - D	Reel of 2500	SN74LV221ADR	LV221A
	SOP - NS	Reel of 2000	SN74LV221ANSR	74LV221A
-40°C to 85°C	SSOP – DB	Reel of 2000	SN74LV221ADBR	LV221A
-40°C to 85°C		Tube of 90	SN74LV221APW	
	TSSOP - PW	Reel of 2000	SN74LV221APWR	LV221A
		Reel of 250	SN74LV221APWT	
	TVSOP - DGV	Reel of 2000	SN74LV221ADGVR	LV221A
	CDIP – J	Tube of 25	SNJ54LV221AJ	SNJ54LV221AJ
–55°C to 125°C	CFP – W	Tube of 150	SNJ54LV221AW	SNJ54LV221AW
−55°C to 125°C	LCCC - FK	Tube of 55	SNJ54LV221AFK	SNJ54LV221AFK

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



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description/ordering information (continued)

The 'LV221A devices are dual multivibrators designed for 2-V to 5.5-V V_{CC} operation. Each multivibrator has a negative-transition-triggered (\overline{A}) input and a positive-transition-triggered (\overline{B}) input, either of which can be used as an inhibit input.

These edge-triggered multivibrators feature output pulse-duration control by three methods. In the first method, the \overline{A} input is low and the \overline{A} input goes high. In the second method, the \overline{A} input is high and the \overline{A} input goes low. In the third method, the \overline{A} input is low, the \overline{A} input is high, and the clear $\overline{(CLR)}$ input goes high.

The output pulse duration is programmable by selecting external resistance and capacitance values. The external timing capacitor must be connected between C_{ext} and R_{ext}/C_{ext} (positive) and an external resistor connected between R_{ext}/C_{ext} and V_{CC} . To obtain variable pulse durations, connect an external variable resistor between R_{ext}/C_{ext} and V_{CC} . The output pulse duration also can be reduced by taking \overline{CLR} low.

Pulse triggering occurs at a particular voltage level and is not related directly to the transition time of the input pulse. The A, B, and CLR inputs have Schmitt triggers with sufficient hysteresis to handle slow input transition rates with jitter-free triggering at the outputs.

Once triggered, the outputs are independent of further transitions of the \overline{A} and B inputs and are a function of the timing components, or the output pulses can be terminated by the overriding clear. Input pulses can be of any duration relative to the output pulse. Output pulse duration can be varied by choosing the appropriate timing components. Output rise and fall times are TTL compatible and independent of pulse duration. Typical triggering and clearing sequences are illustrated in the input/output timing diagram.

The variance in output pulse duration from device to device typically is less than $\pm 0.5\%$ for given external timing components. An example of this distribution for the 'LV221A is shown in Figure 8. Variations in output pulse duration versus supply voltage and temperature are shown in Figure 5.

During power up, Q outputs are in the low state, and \overline{Q} outputs are in the high state. The outputs are glitch free, without applying a reset pulse.

These devices are fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.

Pin assignments are identical to those of the 'AHC123A and 'AHCT123A devices, so the 'LV221A can be substituted for those devices not using the retrigger feature.

For additional application information on multivibrators, see the application report *Designing With The SN74AHC123A and SN74AHCT123A*, literature number SCLA014.

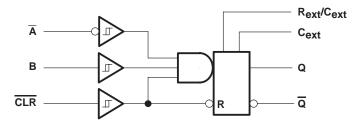


FUNCTION TABLE (each multivibrator)

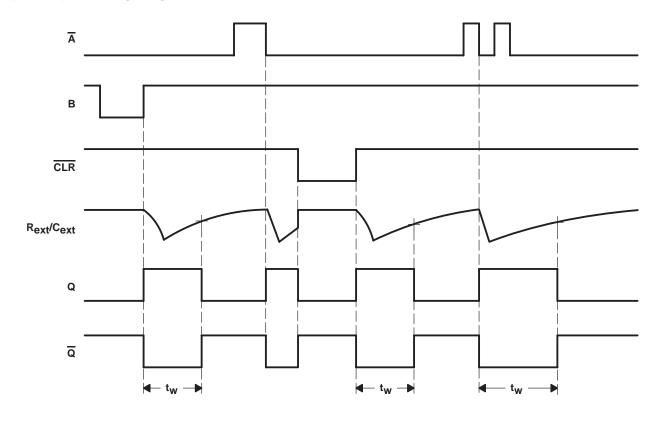
	INPUTS		OUTI	PUTS	
CLR	Ā	В	Ø	Q	FUNCTION
L	Χ	Х	L	Н	Reset
Н	Н	X	L	Н	Inhibit
Н	Χ	L	L	Н	Inhibit
Н	L	\uparrow	Л	T	Outputs enabled
Н	\downarrow	Н	Л	T	Outputs enabled
↑ †	L	Н	Л	T	Outputs enabled

[†] This condition is true only if the output of the latch formed by the NAND gate has been conditioned to the logic 1 state prior to CLR going high. This latch is conditioned by taking either A high or B low while CLR is inactive (high).

logic diagram, each multivibrator (positive logic)



input/output timing diagram





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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{CC}		–0.5 V to 7 V
Input voltage range, V _I (see Note 1)		–0.5 V to 7 V
Output voltage range in high or low state, VO (s	see Notes 1 and 2)	0.5 V to V _{CC} + 0.5 V
Output voltage range in power-off state, VO (see	ee Note 1)	0.5 V to 7 V
Input clamp current, I _{IK} (V _I < 0)		–20 mA
Output clamp current, I _{OK} (V _O < 0)		–50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})		±25 mA
Continuous current through V _{CC} or GND		±50 mA
Package thermal impedance, θ _{JA} (see Note 3)	: D package	
	DB package	82°C/W
	DGV package	120°C/W
	NS package	64°C/W
	PW package	108°C/W
Storage temperature range, T _{stg}		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. This value is limited to 5.5 V maximum.
 - 3. The package thermal impedance is calculated in accordance with JESD 51-7.



recommended operating conditions (see Note 4)

			SN54I	V221A	SN74L	V221A	
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		2	5.5	2	5.5	V
		V _{CC} = 2 V	1.5		1.5		
Maria	High lavel input valtage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	V _{CC} ×0.7		$V_{CC} \times 0.7$		V
VIH	High-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		
		V _{CC} = 2 V		0.5		0.5	
\/	Law law line it walte as	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V
V_{IL}	Low-level input voltage	V _{CC} = 3 V to 3.6 V		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	
VI	Input voltage		0	5.5	0	5.5	V
VO	Output voltage		0	VCC	0	VCC	V
		V _{CC} = 2 V		-50		-50	μΑ
1	High lavel autout august	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	2	-2		-2	
ЮН	High-level output current	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	20	-6		-6	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	Q	-12		-12	
		V _{CC} = 2 V		50		50	μΑ
	Law law Law day day as a second	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2		2	
lOL	Low-level output current	V _{CC} = 3 V to 3.6 V		6		6	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		12		12	
-	Enternal Code and address	V _{CC} = 2 V	5k		5k		0
R _{ext}	External timing resistance	$VCC \ge 3 V$	1k		1k		Ω
C _{ext}	External timing capacitance		No res	striction	No res	triction	pF
Δt/ΔV _{CC}	Power-up ramp rate		1		1		ms/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEST CONDITIONS	.,,	SN54	4LV221A		SN74	LV221A		
PA	RAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
		I _{OH} = -50 μA	2 V to 5.5 V	V _{CC} -0.1			V _{CC} -0.1			
		I _{OH} = -2 mA	2.3 V	2			2			V
VOH		I _{OH} = -6 mA	3 V	2.48			2.48			V
		I _{OH} = -12 mA	4.5 V	3.8			3.8			
		I _{OL} = 50 μA	2 V to 5.5 V			0.1			0.1	
\ ,		I _{OL} = 2 mA	2.3 V			0.4			0.4	V
VOL		I _{OL} = 6 mA	3 V		Š	0.44			0.44	V
		I _{OL} = 12 mA	4.5 V		, S	0.55			0.55	
	R _{ext} /C _{ext} †	V _I = 5.5 V or GND	2 V to 5.5 V		PA	±2.5			±2.5	
Ц		V 55V OND	0		5	±1			±1	μΑ
	A, B, and CLR	$V_I = 5.5 \text{ V or GND}$	0 to 5.5 V	// _G		±1			±1	
ICC	Quiescent	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V	0		20			20	μΑ
			2.3 V	Q		220			220	
١.	Active state	$V_I = V_{CC}$ or GND,	3 V			280			280	
ICC	(per circuit)	$R_{ext}/C_{ext} = 0.5 V_{CC}$	4.5 V			650			650	μΑ
			5.5 V			975			975	
I _{off}		V_I or $V_O = 0$ to 5.5 V	0						5	μΑ
		V V m CND	3.3 V		1.9			1.9	·	. [
Ci		$V_I = V_{CC}$ or GND	5 V		1.9			1.9		pF

[†] This test is performed with the terminal in the off-state condition.

timing requirements over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted) (see Figure 1)

			T _A = 2	25°C	SN54LV221A	SN74LV	/221A	
l			MIN	MAX	MIN MAX	MIN	MAX	UNIT
ſ		CLR	6		6.5	6.5		
	t _W Pulse duration	A or B trigger	6		6.5	6.5		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

			T _A = 2	25°C	SN54LV221A	SN74L\	/221A	
			MIN	MAX	MIN MAX	MIN	MAX	UNIT
	Dulas duration	CLR	5		5	5		
ι _W	Pulse duration	A or B trigger	5		5	5		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

			$T_A = 2$	25°C	SN54LV221A	SN74L\	/221A	LINUT
			MIN	MAX	MIN MAX	MIN	MAX	UNIT
		CLR	5		5	5		
t _W	Pulse duration	A or B trigger	5	·	Q 5	5		ns

PRODUCT PREVIEW information concerns products in the formative or design phase of development. Characteristic data and other specifications are design goals. Texas Instruments reserves the right to change or discontinue these products without notice.



switching characteristics over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted) (see Figure 1)

DADAMETER	FROM	то	TEST	T,	_A = 25°C	;	SN54L\	/221A	SN74LV	/221A	LINUT
PARAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	A or B	Q or Q			14.6*	31.4*	1*	37*	1	37	
^t pd	CLR	Q or Q	C _L = 15 pF		13.2*	25*	1*	29.5*	1	29.5	ns
	CLR trigger	Q or Q			15.2*	33.4*	1*	39*	1	39	
	A or B	Q or Q			16.7	36	1	42	1	42	
^t pd	CLR	Q or Q	C _L = 50 pF		15	32.8	1	34.5	1	34.5	ns
	CLR trigger	Q or Q	•		17.4	38	1 4	44	1	44	
			$C_L = 50 \text{ pF},$ $C_{ext} = 28 \text{ pF},$ $R_{ext} = 2 \text{ k}\Omega$		203	260	Longo	320		320	ns
t _W †		Q or $\overline{\mathbb{Q}}$	$C_L = 50 \text{ pF},$ $C_{ext} = 0.01 \mu\text{F},$ $R_{ext} = 10 k\Omega$	90	100	110	90	110	90	110	μs
			$C_L = 50 \text{ pF},$ $C_{ext} = 0.1 \mu\text{F},$ $R_{ext} = 10 k\Omega$	0.9	1	1.1	0.9	1.1	0.9	1.1	ms
Δt _W ‡			$C_L = 50 pF$		±1						%

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	TEST	T,	_A = 25°C	;	SN54L\	/221A	SN74L	V221A	LINUT
PARAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	A or B	Q or Q			10.2*	20.6*	1*	24*	1	24	
^t pd	CLR	Q or $\overline{\mathbb{Q}}$	C _L = 15 pF		9.3*	15.8*	1*	18.5*	1	18.5	ns
	CLR trigger	Q or $\overline{\mathbb{Q}}$			10.6*	22.4*	1*	26*	1	26	
	Ā or B	Q or Q			11.8	24.1	1	27.5	1	27.5	
^t pd	CLR	Q or Q	C _L = 50 pF		10.6	19.3	1	22	1	22	ns
	CLR trigger	Q or Q			12.3	25.9	1 (29.5	1	29.5	
			$C_L = 50 \text{ pF},$ $C_{ext} = 28 \text{ pF},$ $R_{ext} = 2 \text{ k}\Omega$		186	240	Longo	300		300	ns
t _W †		Q or $\overline{\mathbb{Q}}$	$C_L = 50 \text{ pF},$ $C_{ext} = 0.01 \mu\text{F},$ $R_{ext} = 10 k\Omega$	90	100	110	90	110	90	110	μs
			$C_L = 50 \text{ pF},$ $C_{ext} = 0.1 \mu\text{F},$ $R_{ext} = 10 k\Omega$	0.9	1	1.1	0.9	1.1	0.9	1.1	ms
∆t _W ‡			$C_L = 50 pF$		±1						%

^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.



 $[\]dagger t_W = \text{Pulse duration at Q and } \overline{Q} \text{ outputs}$

 $^{^{\}ddagger}\Delta t_W^{}$ = Output pulse-duration variation (Q and \overline{Q}) between circuits in same package

 $[\]dagger t_W$ = Pulse duration at Q and \overline{Q} outputs

 $[\]ddagger \Delta t_W = \text{Output pulse-duration variation (Q and } \overline{Q} \text{)}$ between circuits in same package

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switching characteristics over recommended operating free-air temperature V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1) range,

24244555	FROM	то	TEST	T,	ղ = 25°C	;	SN54L	V221A	SN74L	V221A	
PARAMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
	A or B	Q or Q			7.1*	12*	1*	14*	1	14	
^t pd	CLR	Q or Q	C _L = 15 pF		6.5*	9.4*	1*	11*	1	11	ns
	CLR trigger	Q or Q			7.3*	12.9*	1*	15*	1	15	
	A or B	Q or Q			8.2	14	1	16	1	16	
^t pd	CLR	Q or Q	$C_L = 50 pF$		7.4	11.4	1	13	1	13	ns
·	CLR trigger	Q or Q			8.6	14.9	1 2	17	1	17	
			$C_L = 50 \text{ pF},$ $C_{ext} = 28 \text{ pF},$ $R_{ext} = 2 \text{ k}\Omega$		171	200	Jongo	240		240	ns
_{tw} †		Q or $\overline{\mathbb{Q}}$	C_L = 50 pF, C_{ext} = 0.01 μ F, R_{ext} = 10 k Ω	90	100	110	90	110	90	110	μs
			C_L = 50 pF, C_{ext} = 0.1 μ F, R_{ext} = 10 k Ω	0.9	1	1.1	0.9	1.1	0.9	1.1	ms
∆t _W ‡			$C_L = 50 pF$		±1						%

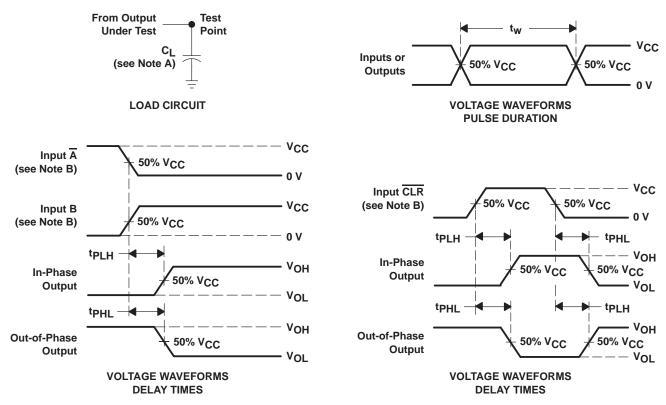
^{*} On products compliant to MIL-PRF-38535, this parameter is not production tested.
† t_W = Pulse duration at Q and \overline{Q} outputs
‡ Δt_W = Output pulse-duration variation (Q and \overline{Q}) between circuits in same package

operating characteristics, T_A = 25°C

	PARAMETER	TEST CO	NDITIONS	VCC	TYP	UNIT
_	Down discination consists	C 50 = E	f 40 MH-	3.3 V	50	
Cpd	Power dissipation capacitance	$C_L = 50 \text{ pF},$	f = 10 MHz	5 V	51	pF



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f = 3 \text{ ns}$, $t_f = 3 \text{ ns}$.
- C. The outputs are measured one at a time, with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

APPLICATION INFORMATION

caution in use

To prevent malfunctions due to noise, connect a high-frequency capacitor between V_{CC} and GND, and keep the wiring between the external components and C_{ext} and R_{ext}/C_{ext} terminals as short as possible.

power-down considerations

Large values of C_{ext} can cause problems when powering down the 'LV221A because of the amount of energy stored in the capacitor. When a system containing this device is powered down, the capacitor can discharge from V_{CC} through the protection diodes at pin 2 or pin 14. Current through the input protection diodes must be limited to 30 mA; therefore, the turn-off time of the V_{CC} power supply must not be faster than $t = V_{CC} \times C_{ext}/30$ mA. For example, if $V_{CC} = 5$ V and $C_{ext} = 15$ pF, the V_{CC} supply must turn off no faster than $t = (5 \text{ V}) \times (15 \text{ pF})/30$ mA = 2.5 ns. Usually, this is not a problem because power supplies are heavily filtered and cannot discharge at this rate. When a more rapid decrease of V_{CC} to zero occurs, the 'LV221A can sustain damage. To avoid this possibility, use external clamping diodes.

output pulse duration

The output pulse duration, t_W , is determined primarily by the values of the external capacitance (C_T) and timing resistance (R_T). The timing components are connected as shown in Figure 2.

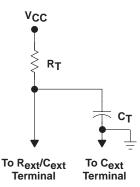


Figure 2. Timing-Component Connections

The pulse duration is given by:

$$t_{w} = K \times R_{T} \times C_{T}$$
 if C_{T} is ≥ 1000 pF, $K = 1.0$

or

if C_T is < 1000 pF, K can be determined from Figure 7

where:

t_w = pulse duration in ns

 R_T = external timing resistance in $k\Omega$ C_T = external capacitance in pF

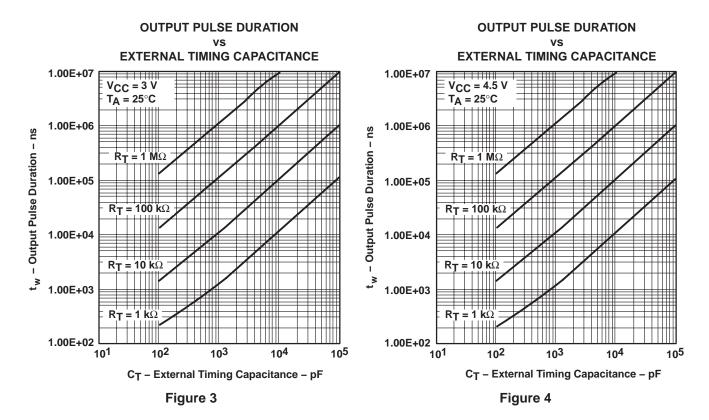
o | = external dapaditarioe ii

K = multiplier factor

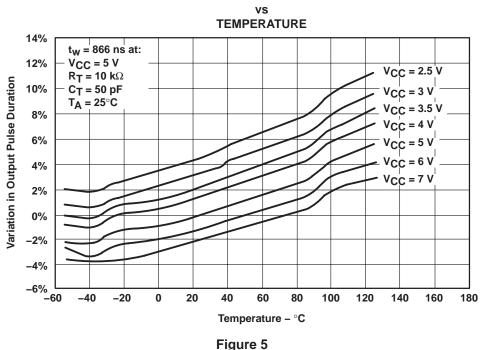
Equation 1 and Figure 3 or 4 can be used to determine values for pulse duration, external resistance, and external capacitance.



APPLICATION INFORMATION[†]



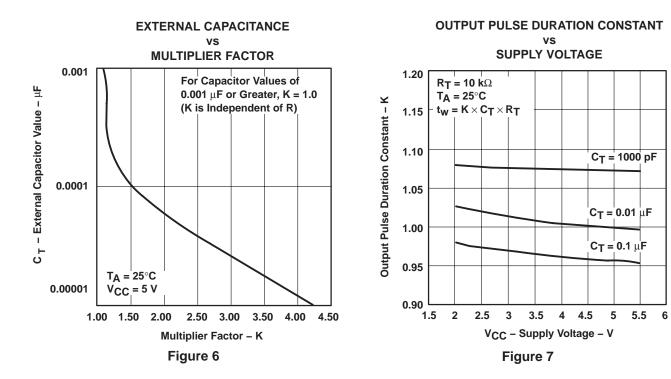
VARIATION IN OUTPUT PULSE DURATION



† Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.



APPLICATION INFORMATION[†]



DISTRIBUTION OF UNITS vs OUTPUT PULSE DURATION

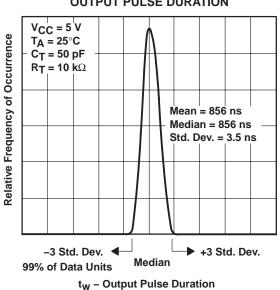


Figure 8

[†] Operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied.







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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp (3)
SN74LV221AD	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LV221ADBR	ACTIVE	SSOP	DB	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LV221ADGVR	ACTIVE	TVSOP	DGV	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LV221ADR	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LV221ANSR	ACTIVE	SO	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
SN74LV221APW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LV221APWE4	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LV221APWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LV221APWRE4	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LV221APWT	ACTIVE	TSSOP	PW	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
SN74LV221APWTE4	ACTIVE	TSSOP	PW	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DGV (R-PDSO-G**)

24 PINS SHOWN

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194

D (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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